

Dear customers,

About the change in the name such as "Oki Electric Industry Co. Ltd." and "OKI" in documents to OKI Semiconductor Co., Ltd.

The semiconductor business of Oki Electric Industry Co., Ltd. was succeeded to OKI Semiconductor Co., Ltd. on October 1, 2008. Therefore, please accept that although the terms and marks of "Oki Electric Industry Co., Ltd.", "Oki Electric", and "OKI" remain in the documents, they all have been changed to "OKI Semiconductor Co., Ltd.". It is a change of the company name, the company trademark, and the logo, etc., and NOT a content change in documents.

October 1, 2008 OKI Semiconductor Co., Ltd.

# OKI SEMICONDUCTOR CO., LTD.

550-1 Higashiasakawa-cho, Hachioji-shi, Tokyo 193-8550, Japan http://www.okisemi.com/en/

# **OKI** Semiconductor

# MSM58321

### **REAL TIME CLOCK/CALENDAR**

#### DESCRIPTION

The MSM 58321 is a metal gate CMOS Real Time Clock/Calendar with a battery backup function for use in bus-oriented microprocessor applications.

The 4-bit bidirectional bus line method is used for the data I/O circuit; the clock is set, corrected, or read by accessing the memory.

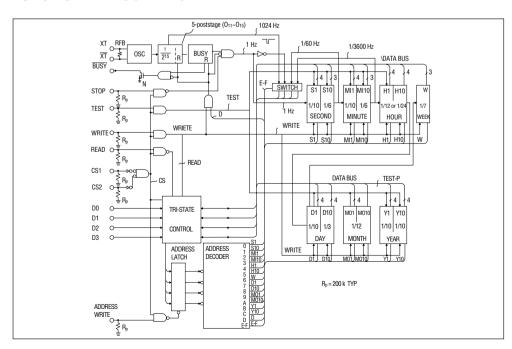
The time is read with 4-bit DATA I/O, ADDRESS WRITE, READ, and BUSY; it is written with 4-bit DATA I/O, ADDRESS WRITE, WRITE, and BUSY.

#### **FEATURES**

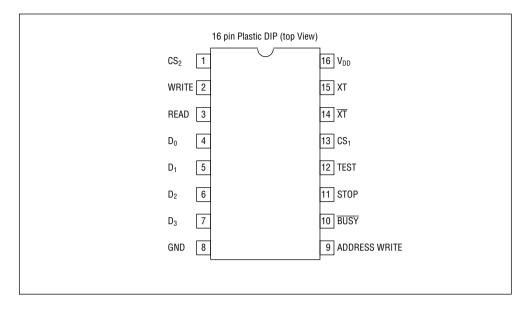
- 7 Function-Second, Minute, Hour, Day, Day-of-Week, Month, Year
- Automatic leap year calender
- 12/24 hour format
- Frequency divider 5-poststage reset
- Reference signal output

- 32.768 kHz crystal controlled operation
- Single 5V power supply
- Back-up battery operation to VDD = 2.2V
- Low power dissipation 90 μW max. at V<sub>DD</sub> = 3V 2.5 mW max. at V<sub>DD</sub> = 5V
- 16 pin plastic DIP (DIP 16-P-300)

#### **FUNCTIONAL BLOCK DIAGRAM**



## **PIN CONFIGURATION**



### **REGISTER TABLE**

Address		Addres	s input		Register		Data input/ output  D <sub>0</sub> D <sub>1</sub> D <sub>2</sub> D <sub>3</sub> Count value		Remarks		Remarks		
Auditoss	D <sub>0</sub> (A <sub>0</sub> )	D <sub>1</sub> (A <sub>1</sub> )	D <sub>2</sub> (A <sub>2</sub> )	D <sub>3</sub> (A <sub>3</sub> )	Name	D <sub>0</sub>			ue	rional is			
0	0	0	0	0	S <sub>1</sub>	*	*	*	*	0	to	9	
1	1	0	0	0	S <sub>10</sub>	*	*	*		0	to	5	
2	0	1	0	0	MI <sub>1</sub>	*	*	*	*	0	to	9	
3	1	1	0	0	MI <sub>10</sub>	*	*	*		0	to	5	
4	0	0	1	0	H <sub>1</sub>	*	*	*	*	0	to	9	
5	1	0	1	0	H <sub>10</sub>	*	*	*	•	0~1	or 0	~2	D2 = 1 specifies PM, D2 = 0 specifies AM, D3 = 1 specifies 24-hour timer, and D3 = 0 specifies 12-hour timer. When D3 = 1 is written, the D2 bit is reset inside the IC.
6	0	1	1	0	W	*	*	*		0	to	6	
7	1	1	1	0	D <sub>1</sub>	*	*	*	*	0	to	9	
8	0	0	0	1	D <sub>10</sub>	*	*	⊕	0	0	to	3	The D2 and D3 bits in D10 are used to select a leap year.  Remainder obtained by dividing the
9	1	0	0	1	MO <sub>1</sub>	*	*	*	*	0	to	9	Calendar D <sub>2</sub> D <sub>3</sub> Remainder obtained by dividing the
Α	0	1	0	1	MO <sub>10</sub>	*				0	to	1	Gregorian calendar 0 0 0
В	1	1	0	1	Y <sub>1</sub>	*	*	*	*	0	to	9	1 0 3
C	0	0	1	1	Y <sub>10</sub>	*	*	*	*	0	to	9	1 1 1
D	1	0	1	1									A selector to reset 5 poststages in the 1/2 <sup>15</sup> frequency divider and the BUSY circuit. They are reset when this code is latched with ADDRESS LATCH and the WRITE input goes to 1.
E~F	0/1	1	1	1									A selector to obtain reference signal output. Reference signals are output to $D0-D3$ when this code is latched with ADDRESS LATCH and READ input goes to 1.

#### Note:

- (1) There are no bits in blank fields for data input/output. 0 signals are output by reading and data is not stored by writing because there are no bits.
- (2) The bit with marked  $^{\odot}$  is used to select the 12/24-hour timer and the bits marked  $^{\odot}$  are used to select a leap year. These three bits can be read or written.
- (3) When signals are input to bus lines D0 D3 and ADDRESS WRITE goes to 1 for address input, ADDRESS information is latched with ADDRESS LATCH.

#### **ELECTRICAL CHARACTERISTICS**

## **Absolute Maximum Ratings**

Rating	Symbol	Condition	Value	Unit
Power voltage	V <sub>DD</sub>	Ta = 25°C	-0.3 to 6.5	V
Input voltage	VI	Ta = 25°C	-0.3 to V <sub>DD</sub> +0.3	V
Output voltage	V <sub>0</sub>	Ta = 25°C	-0.3 to V <sub>DD</sub> +0.3	V
Storage temperature	T <sub>stg</sub>	_	-55 to +150	°C

# **Operating Conditions**

Rating	Symbol	Condition	Value	Unit
Power voltage	VDD	_	4.5 to 6	V
Date hold voltage	VDH	_	2.2 to 6	V
Crystal frequency	f(XT)	_	32.768	kHz
Operating temperature	Тор	_	-30 to +85	°C

**Note:** The data hold voltage guarantees the clock operations, though it does not guarantee operations outside the IC and data input/output.

## **DC Characteristics**

 $(V_{DD} = 5V \pm 5\%, Ta = -30 \sim +85^{\circ}C)$ 

Rating	Symbol	Condition	Min.	Тур.	Max.	Unit	
II input valtage	V <sub>IH1</sub>	- Note 1	3.6	_	_	V	
H input voltage	V <sub>IH2</sub>	- Note 2	V <sub>DD</sub> -0.5	-	_	V	
L input voltage	V <sub>IL</sub>	_	_	-	0.8	V	
L output voltage	V <sub>OL</sub>	Io = 1.6 mA	_	-	0.4	V	
L output current	loL	Vo = 0.4 V	1.6	_	_	mA	
U input ourrant	I <sub>IH1</sub>	VI = VDD Note3	10	30	80		
H input current	I <sub>IH2</sub>	VI = VDD Note4	-	_	1	μA	
L input current	I <sub>IL</sub>	Vı = 0V	_	_	-1	μA	
Input capacity	Cı	f = 1 MHz	_	5	_	pF	
Current consumption	I <sub>DD</sub>	f = 32.768  kHz VDD = 5V/VDD = 3V	-	100/15	500/30	μA	

Note:

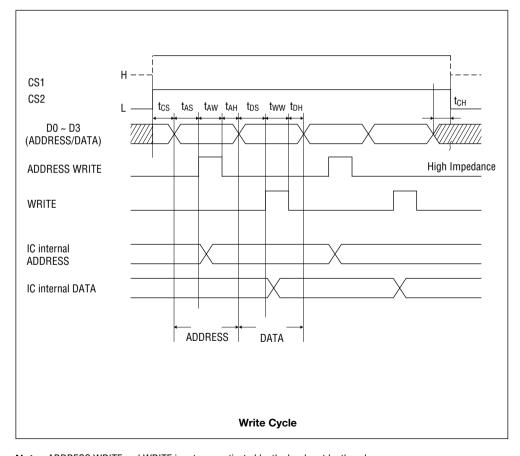
- 1. CS<sub>2</sub>, WRITE, READ, ADDRESS WRITE, STOP, TEST, D<sub>0</sub> ~ D<sub>3</sub>
- CS-
- 3. CS<sub>1</sub>, CS<sub>2</sub>, WRITE, READ, ADDRESS WRITE, STOP, TEST
- 4.  $D_0 \sim D_3$

# **Switching Characteristics**

# (1) WRITE mode

 $(V_{DD} = 5V \pm 5\%, Ta = 25^{\circ}C)$ 

Rating	Symbol	Condition	Min.	Тур.	Max.	Unit
CS setup time	tcs	_	0	_	-	μs
CS hold time	t <sub>CH</sub>	-	0	_	-	μs
Address setup time	t <sub>AS</sub>	-	0	-	_	μs
Address write pulse width	t <sub>AW</sub>	-	0.5	_	-	μs
Address hold time	t <sub>AH</sub>	-	0.1	_	-	μs
Data setup time	t <sub>DS</sub>	-	0	_	_	μs
Write pulse width	t <sub>WW</sub>	-	2	_	_	μs
Data hold time	t <sub>DH</sub>	_	0	_	_	μs



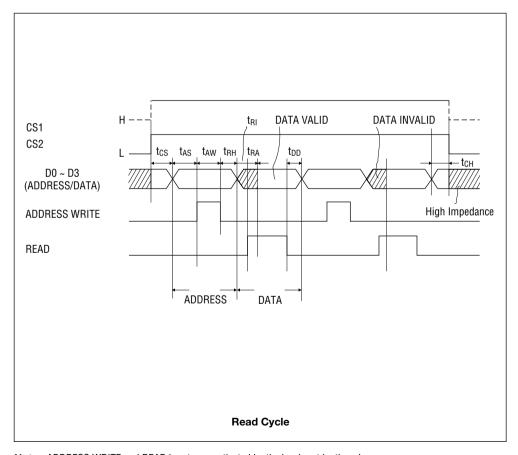
Note: ADDRESS WRITE and WRITE inputs are activated by the level, not by the edge.

# (2) READ mode

 $(V_{DD} = 5V \pm 5\%, Ta = 25^{\circ}C)$ 

Rating	Symbol	Condition	Min.	Тур.	Max.	Unit
CS setup time	tcs	_	0	_	_	μs
CS hold time	tсн	_	0	_	-	μs
Address setup time	tas	-	0	-	_	μs
Address write pulse width	t <sub>AW</sub>	_	0.5	_	_	μs
Address hold time	t <sub>AH</sub>	_	0.1	_	_	μs
Read access time	t <sub>RA</sub>	_	_	_	see Note 1	μs
Read delay time	t <sub>DD</sub>	_	_	_	1	μs
Read inhibit time	t <sub>RI</sub>	-	0	_	_	μs

Note 1. 
$$t_{RA} = 1 \ \mu s + CR \ ln \ (\frac{V_{DD}}{V_{DD} - V_{IH} \ min})$$



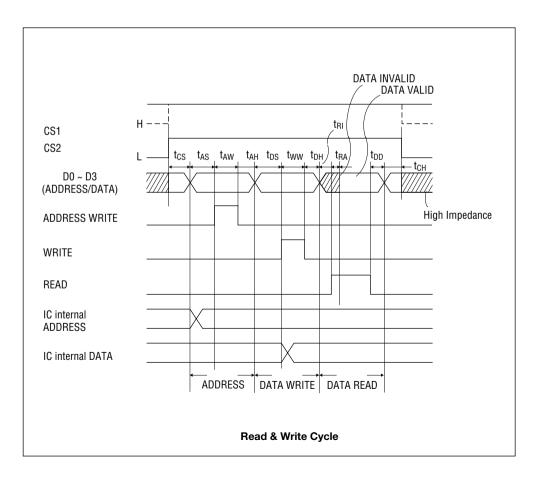
**Note:** ADDRESS WRITE and READ inputs are activated by the level, not by the edge.

# (3) WRITE & READ mode

 $(V_{DD} = 5V \pm 5\%, Ta = 25^{\circ}C)$ 

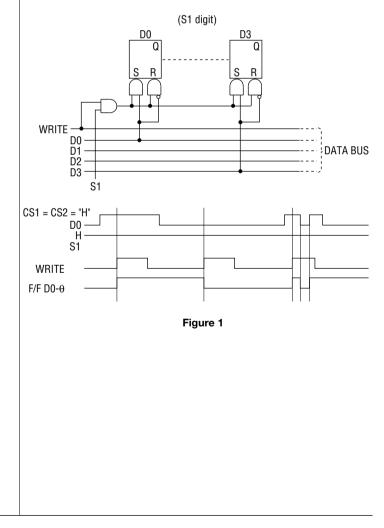
Rating	Symbol	Condition	Min.	Тур.	Max.	Unit
CS setup time	t <sub>CS</sub>	_	0	_	_	μs
CS hold time	t <sub>CH</sub>	-	0	-	-	μs
Address setup time	t <sub>AS</sub>	-	0	-	-	μs
Address write pulse width	t <sub>AW</sub>	-	0.5	-	-	μs
Address hold time	t <sub>AH</sub>	-	0.1	-	_	μs
Data setup time	t <sub>DS</sub>	-	0	_	_	μs
Write pulse width	t <sub>WW</sub>	-	2	-	-	μs
Data hold time	t <sub>DH</sub>	_	0	_	_	μs
Read access time	t <sub>RA</sub>	_	_	_	see Note 1	μs
Read delay time	t <sub>DD</sub>	-	_	_	1	μs
Read inhibit time	t <sub>RI</sub>	-	0	_	_	μs

Note 1. 
$$t_{RA} = 1 \ \mu s + CR \ ln \ (\frac{V_{DD}}{V_{DD} - V_{IH} \ min})$$

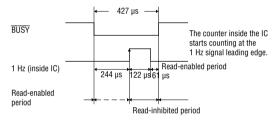


# **PIN DESCRIPTION**

Name	Pin No.	Description
CS <sub>2</sub>	1	Chip select pins. These pins enable the interface with the external circuit when both of these pins are set at H level simultaneously.
CS <sub>1</sub>	13	If one of these pins is set at L level, STOP, TEST, WRITE, READ, ADDRESS WRITE pins and $D_0 \sim D_3$ pins are inactivated. Since the threshold voltage VT for the $\text{CS}_1$ pin is higher than that for other pins, it shuold be connected to the detector of power circuit and peripherals and $\text{CS}_2$ is to be connected to the microcontroller.
WRITE	2	WRITE pin is used to write data; it is activated when it is at the H level. Data bus data inside the IC is loaded to the object digit while this WRITE pin is at the H level, not at the WRITE input edge. Refer to Figure 1 below.



Name	Pin No.	Description
READ	3	READ pin is used to read data; it is activated when it is at the H level. Address contents are latched with ADDRESS LATCH inside the IC at the $D_0 \sim D_3$ and ADDRESS WRITE pins to select the object digit, then an H-level signal is input to the READ pin to read data. If a count operation is continued by setting the STOP input to the L level, read operation must be performed, in principle, while the $\overline{BUSY}$ output is at the H level. While the $\overline{BUSY}$ output is at the L level, count operations are performed by digit counters and read data is not guaranteed, therefore, read operations are inhibited in this period. Figure 2 shows a time chart of the $\overline{BUSY}$ output, 1 Hz signal inside the IC, and READ input. A read operation is stopped temporarily within a period of 244 $\mu s$ from the $\overline{BUSY}$ output trailing edge and it is restarted when the $\overline{BUSY}$ output goes to the H level again.



Read operation is enabled in this period: however, it is used for program switching.

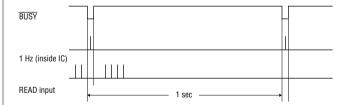


Figure 2

If the counter operation is stopped by setting the STOP input to the H level, read operations are enabled regardless of the  $\overline{\text{BUSY}}$  output.

A read operation is enabled by microcomputer software regardless of the BUSY output during the counter operation by setting the STOP input to the L level. In this method, read operations are performed two or more times continuously and data that matches twice is used as guaranteed data.

Name	Pin No.	Description
D <sub>0</sub> ~ D <sub>3</sub>	4 ~ 7	Data input/output pins. (Bidirectional bus). The output is a open-drain type and 4.7 k $\Omega$ ~ 10 k $\Omega$ pull-up registers are required utilize these pins as output pins.
GND	8	Ground pin.
ADDRESS WRITE	9	ADDRESS WRITE pin is used to load address information from the $D_0 \sim D_3$ I/O bus pins to the ADDRESS LATCH inside the IC; it is activated when it is at the H level. This input is activated by the level, not by the edge. Figure 3 shows the relationships between the $D_0$ address input, ADDRESS WRITE input, and ADDRESS LATCH input/output.
		D <sub>0</sub> input
		ADDRESS WRITE
		$ \begin{array}{c} \text{ADDRESS LATCH} \\ \text{(inside IC)} \end{array} \left\{ \begin{array}{c} \text{DI}_0 \\ \text{L} \\ \text{DO}_0 \\ \text{LATCH output} \end{array} \right. $
		Figure 3
BUSY	10	BUSY pin outputs the IC operation state. It is N-channel MOSFET open-drain output. An external pull-up resistor of 4.6 kΩ or more must be connected (see Figure 4) to use the BUSY output. The signals are output in negative logics. If the oscillator oscillates at 32.768 kHz, the frequency is always 1 Hz regardless of the CS1 and CS2 unless the D output of the ADDRESS DECODER inside the IC is H (CODE = H•L•H•H) and CS1 = CS2 = WRITE = H. Figure 5 shows the BUSY output time chart.    A.7 kΩ or more   +5V   BUSY   BUSY
		The counter inside the IC starts counting at the 1 Hz (inside IC)  1 Hz (inside IC)  244 µs 122 µs6 µs  427 µs  Read/write-inhibited period
		BUSY  1 Hz (inside IC)   1 sec
		Figure 5

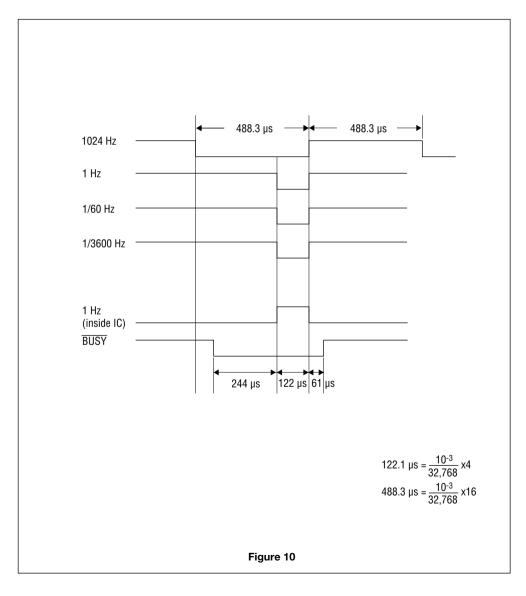
STOP  The STOP pin is used to input on/off control for a 1 Hz signal. When this pin goes to the H level, 1 Hz signals are inhibited and counting for all digits succeeding the S1 digit is stopped. When this pin goes to the L level, norma operations are performed; the digits are counted up. This STOP input contro stopping digit counting. Writing of external data in digits can be assured by setting the STOP input to the H level to stop counting, then writing sequential from the low-order digits.	al ols
TEST  12  The TEST pin is used to test this IC; it is normally open or connected to GND. is recommended to connect it to GND to safeguard against malfunctions from noise.  The TEST pulse can be input to the following nine digits: S1, S10, M10, H1, D1 (W), M01, Y1 and Y10  When a TEST pulse is input to the D1 digit, the W digit is also counted up simultaneously.  Input a TEST pulse as follows: Set the address to either digit explained above, then input a pulse to the TEST while GS1 = CS2 = STOP = H and WRITE = L. The specified and succeeding are counted up. (See Figure 6)  Figure 6  A digit is counted up at the leading edge (changing point from L to H) of a TE pin input pulse. The pulse condition for TEST pin input at V <sub>DD</sub> = 5V ±5% is described in Figure 7 below.  Figure 7	T pin digits

Name	Pin No.	Description
XT XT	14 15	Oscillator pin. A 32.768 kHz crystal oscillator, capacitor and trim capacitor for frequency adjustment are to be connected as shown in Figure 8 below.
		GND or $V_{DD}$ $C1$ $XT$ $R_{FB}$ $R_$
		Figure 8
		If an external clock is to be used for MSM58321's oscillation source, the external clock is to be input to XT, while $\overline{\text{XT}}$ should be left open. Refer to the Figure 9 below.
		CMOS  OT +5V  TTL  MSM58321
VDD	16	Figure 9  Power supply pin. Refer to the application circuit.

## **REFERENCE SIGNAL OUTPUT**

Reference signals are output from the  $D_0 \sim D_3$  pins under the following conditions:

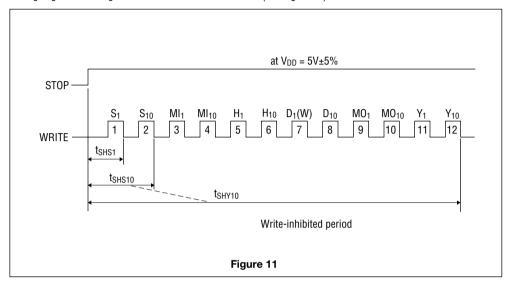
Conditions	Output pin	Reference signal frequency	Pulse width	Output logic
WRITE = L	D <sub>0</sub>	1024 Hz	488.3 μs	Pisitive logic
READ = H	D <sub>1</sub>	1 Hz	122.1 µs	Negative logic
CS1 = CS2 = H	D <sub>2</sub>	1/60 Hz	122.1 µs	Negative logic
ADDRESS = E or F	D <sub>3</sub>	1/3600 Hz	122.1 µs	Netgative logic



#### **APPLICATION NOTES**

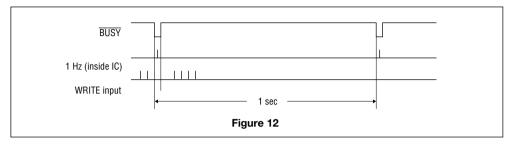
#### **WRITE and STOP**

Note that the timing relationship between the STOP and WRITE inputs vary by the related digit when counting is stopped by the STOP input to write data. The time  $(t_{SH})$  between the STOP input leading edge and WRITE input trailing edge for each digit is limited to the minimum value. (See Figure 11)



 $t_{SHS1}=1~\mu s,~t_{SHS10}=2~\mu s,~t_{SHM11}=3~\mu s,~t_{SHM10}=4~\mu s,~t_{SHH1}=5~\mu s,~t_{SHH10}=6~\mu s,~t_{SHD1}=7~\mu s,~t_{SHW}=7~\mu s,~t_{SHD10}=8~\mu s,~t_{SHM01}=9~\mu s,~t_{SHM010}=10~\mu s,~t_{SHY1}=11~\mu s,~t_{SHY10}=12~\mu s.$ 

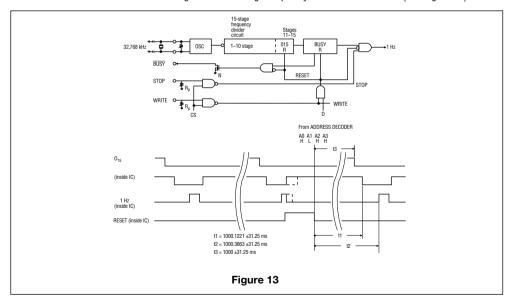
If a count operation is continued by setting the STOP input to the L level, write operation must be performed, in principle, while the  $\overline{BUSY}$  output is at the H level. While the  $\overline{BUSY}$  output is at the L level, count operations are performed by the digit counters and write operation is inhibited, but there is a marginal period of 244  $\mu$ s from the  $\overline{BUSY}$  output trailing edge. If the  $\overline{BUSY}$  output goes to the L level during a write operation, the write operation is stopped temporarily within 244  $\mu$ s and it is restarted when the  $\overline{BUSY}$  output goes to the H level again. Figure 12 shows a time chart of  $\overline{BUSY}$  output, 1 Hz signal inside the IC, and WRITE input.



## Frequency divider and BUSY circuit reset

If A0  $\sim$  A3 = H•L•H•H is input to ADDRESS DECODER, the DECODER output (D) goes to the H level. If CS1 = CS2 = H and WRITE = H in this state, the 5 poststage in the 15-stage frequency divider and the  $\overline{\text{BUSY}}$  circuit are reset.

In this period, the BUSY output remains at the H level and the 1 Hz signal inside the IC remains at the L level, and counting is stopped. If this reset is inactivated while the oscillator operates, the BUSY output goes to the L level after 1000.1221 ±31.25 ms and the 1 Hz signal inside the IC goes to the H level after 1000.3663 ±31.25 ms. These times are not the same because the first ten stages in the 15-stage frequency divider are not reset. (See Figure 13)



#### Selection of leap year

This IC is designed to select leap year automatically.

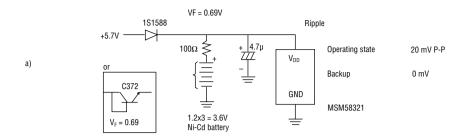
Four types of leap years can be selected by writing a select signal in the D2 and D3 bits of the D10 digit (CODE = L - L - L - L). (See table 1 for the functions.)

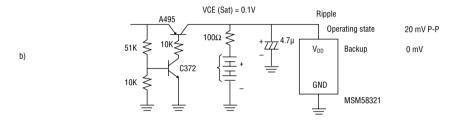
Gregorian calendar or other calendars can be set arbitrarily in the Y1 and Y10 digits of this IC. There is a leap year every four years and the year number varies according to the calendar used. There are four combinations of year numbers and leap years. (See the Table below).

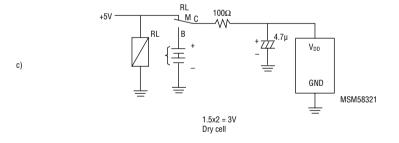
- No. 1: Gregorian calendar year. The remainder obtained by dividing the leap year number by 4 is 0.
- No. 2: The remainder obtained by dividing the leap year number by 4 is 3.
- No. 3: The remainder obtained by dividing the leap year number by 4 is 2.
- No. 4: The remainder obtained by dividing the leap year number by 4 is 1.

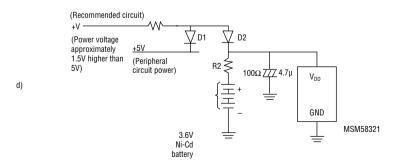
No.1	Calendar	D10 digit		Remainder obtained by		
NO. I		D2	D3	dividing the leap year number by 4	Leap years (examples)	
1	Gregorian	L	L	0	1980, 1984, 1988, 1992 1996, 2000, 2004	
2		Н	L	3	(83) (87) (91) (95) (99) 55, 59, 63, 67, 71, 75, 79	
3		L	Н	2	82, 86, 90, 94, 98, 102, 106	
4		Н	Н	1	81, 85, 89, 93, 97, 101, 105	

## **APPLICATION EXAMPLE - POWER SUPPLY CIRCUIT**









Note: Use the same diodes for D1 and D2 to reduce the level difference between +5V and VDD of the MSM58321.